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ON Semiconductor®

FQD2N90 / FQU2N90

N-Channel QFET® MOSFET

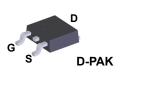
900 V, 1.7 A, 7.2 Ω

Description

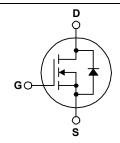
This N-Channel enhancement mode power MOSFET is produced using ON Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 1.7 A, 900 V, $R_{DS(on)}$ = 7.2 Ω (Max.) @ V_{GS} = 10 V, I_{D} = 0.85 A
- Low Gate Charge (Typ. 12 nC)
- Low Crss (Typ. 5.5 pF)
- 100% Avalanche Tested
- RoHS Compliant







Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter		FQD2N90TM FQU2N90TU-WS FQU2N90TU-AM002	Unit	
V _{DSS}	Drain-Source Voltage		900	V	
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		1.7	Α	
			1.08	Α	
I _{DM}	Drain Current - Pulsed	(Note 1)	6.8	Α	
V _{GSS}	Gate-Source Voltage		± 30	V	
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	170	mJ	
I _{AR}	Avalanche Current	(Note 1)	1.7	Α	
E _{AR}	Repetitive Avalanche Energy	(Note 1)	5.0	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.0	V/ns	
P _D	Power Dissipation (T _A = 25°C) *		2.5	W	
	Power Dissipation (T _C = 25°C)		50	W	
	- Derate above 25°C		0.4	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C	

Thermal Characteristics

Symbol	Parameter	FQD2N90TM FQU2N90TU-WS FQU2N90TU-AM002	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	2.5		
В	Thermal Resistance, Junction to Ambient (minimum pad of 2 oz copper), Max.	110	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (*1 in² pad of 2 oz copper), Max.	50		

Unit

Max

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQD2N90TM	FQD2N90	D-PAK	Tape and Reel	330 mm	16 mm	2500 units
FQU2N90TU-WS	FQU2N90S	I-PAK	Tube	N/A	N/A	75 units
FQU2N90TU-AM002	FQU2N90	I-PAK	Tube	N/A	N/A	75 units

Test Conditions

Min

Тур

12

2.8

6.1

(Note 4)

15

nC

nC

nC

Electrical Characteristics T_C = 25°C unless otherwise noted.

Parameter

Symbol

					7.		
Off Cha	aracteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		900			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 2	25°C		1.0		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 900 V, V _{GS} = 0 V				10	μΑ
		V _{DS} = 720 V, T _C = 125°C				100	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V				100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
	aracteristics	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\			I	T = 0	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 0.85 A			5.6	7.2	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 50 V, I _D = 0.85 A			1.7		S
Dynam C _{iss}	ic Characteristics	<u> </u>			390	500	nE.
Coss	Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$			45	60	pF pF
	Reverse Transfer Capacitance	f = 1.0 MHz			5.5	7.0	pF pF
C _{rss}	Reverse Transfer Capacitance				5.5	7.0	þг
Switch	ing Characteristics						
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 450 \text{ V}, I_{D} = 2.2 \text{ A},$ $R_{G} = 25 \Omega$			15	40	ns
t _r	Turn-On Rise Time				35	80	ns
t _{d(off)}	Turn-Off Delay Time	- 1.6 232			20	50	ns
t _f	Turn-Off Fall Time	(N	ote 4)		30	70	ns
•							

Drain-Source Diode Characteristics and Maximum Ratings

I _S	Maximum Continuous Drain-Source Diode Forward Current				1.7	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				6.8	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 1.7 A			1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 2.2 A,		400		ns
Q _{rr}	Reverse Recovery Charge	dI _F / dt = 100 A/μs		1.6		μC

V_{GS} = 10 V

 $V_{DS} = 720 \text{ V}, I_{D} = 2.2 \text{ A},$

 Q_{gs}

 Q_{gd}

- **Notes:** 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 111 mH, I_{AS} = 1.7 A, V_{DD} = 50 V, R_G = 25 Ω , Starting T_J = 25°C 3. $I_{SD} \le 2.2$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le BV_{DSS}$, Starting T_J = 25°C 4. Essentially independent of operating temperature

Total Gate Charge

Gate-Source Charge

Gate-Drain Charge

Typical Characteristics

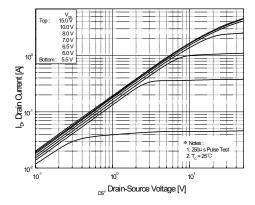


Figure 1. On-Region Characteristics

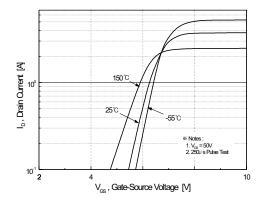


Figure 2. Transfer Characteristics

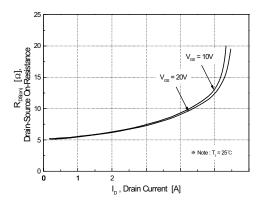


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

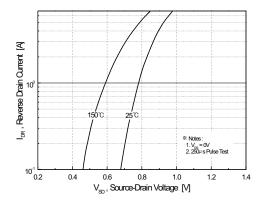


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

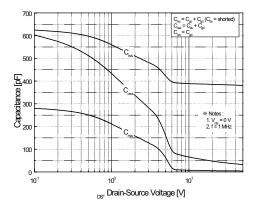


Figure 5. Capacitance Characteristics

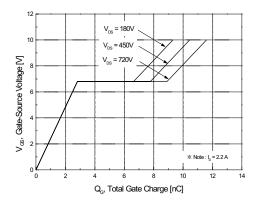


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

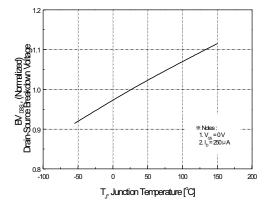


Figure 7. Breakdown Voltage Variation vs. Temperature

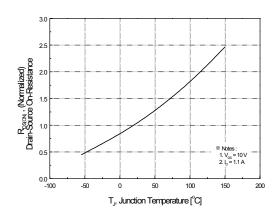


Figure 8. On-Resistance Variation vs. Temperature

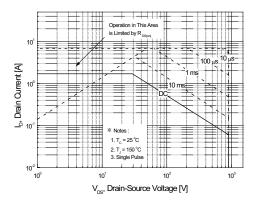


Figure 9. Maximum Safe Operating Area

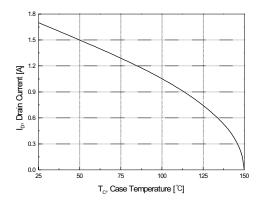


Figure 10. Maximum Drain Current vs. Case Temperature

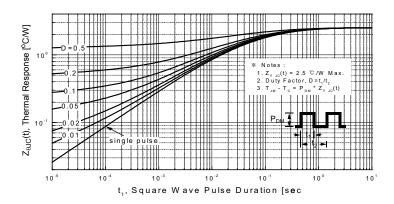


Figure 11. Transient Thermal Response Curve

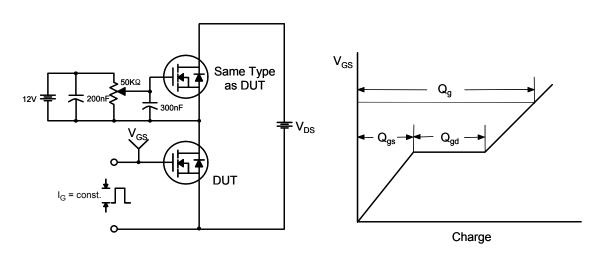


Figure 12. Gate Charge Test Circuit & Waveform

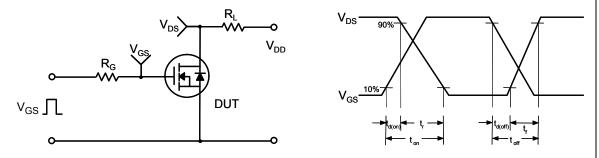


Figure 13. Resistive Switching Test Circuit & Waveforms

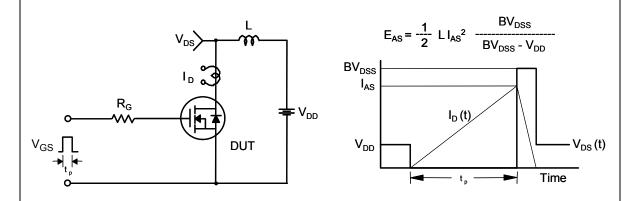
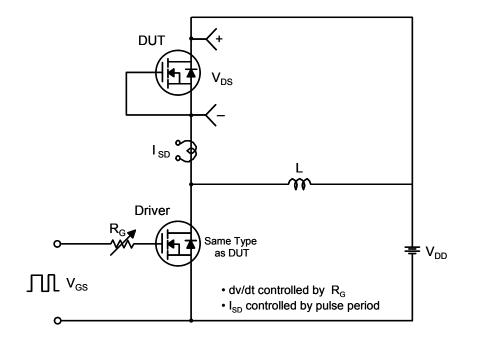


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



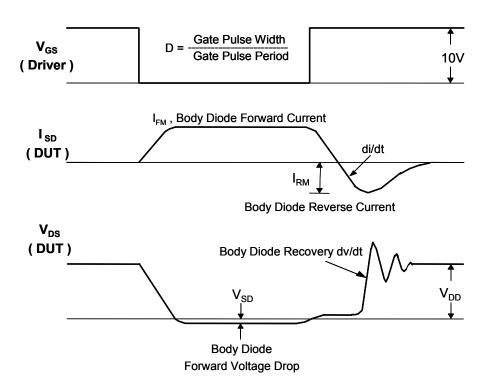
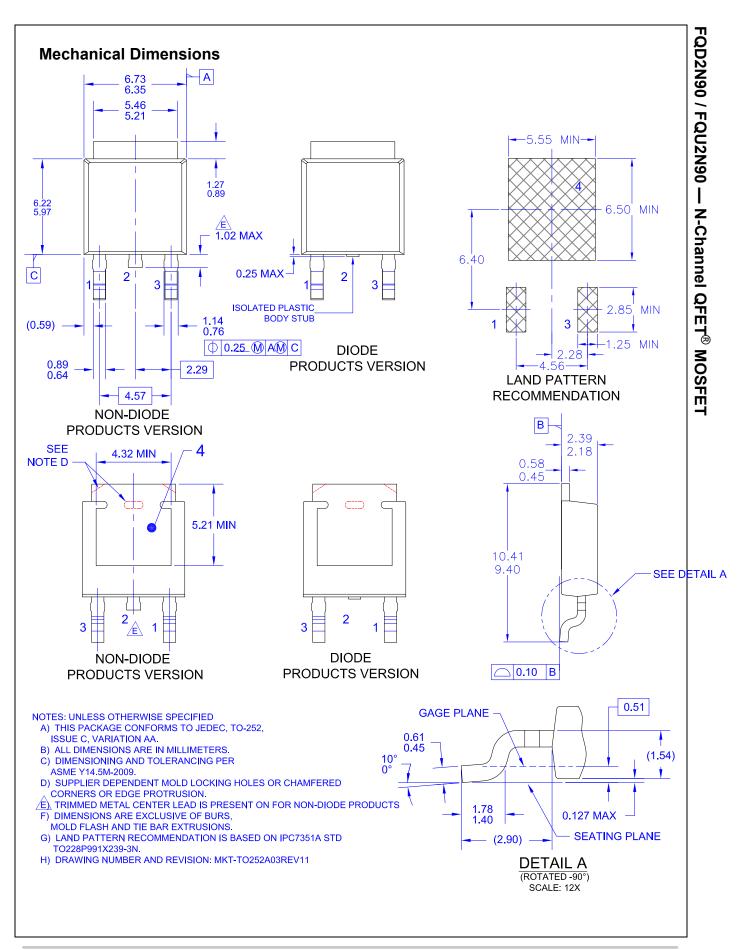
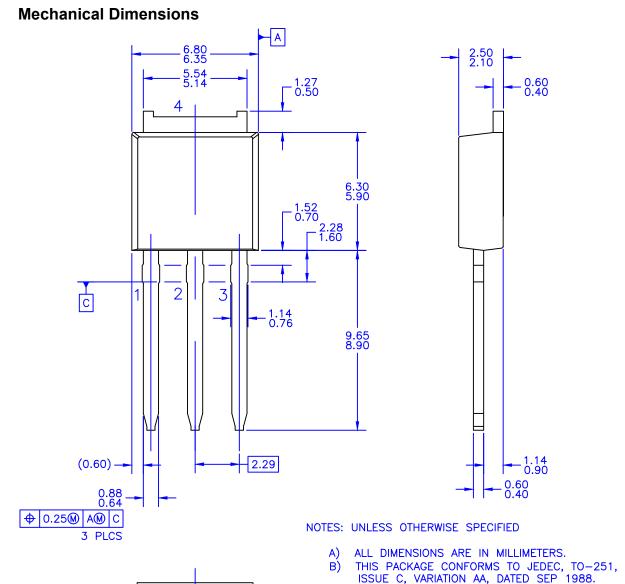


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





- C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- D) DRAWING NUMBER AND REVISION: MKT-T0251A03REV2

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